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**(54) Heater element for a tube connecting device**

Heizelement für eine Schlauch-Ankuppel-Anordnung

Élément chauffant pour dispositif de connexions de tube

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**HEINE 'Hot Idea: PRINT A HEATER'**

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## Description

This invention relates to a heater element suitable for use in a tube connecting device, wherein a set of tubes are melted and cut to be connected with each other by heating under a sterilized condition.

When a dialysate bag and/or a waste liquid bag are changed in a continuous ambulatory peritoneal dialysis (CAPD), for example, or when tubes are connected to a blood-collecting bag and/or a blood component bag in a blood transfusion system, it is necessary to connect the tubes with each other in a sterilized condition.

There has been disclosed a tube connecting device for use in the situation like above, which connects a set of tubes with each other by heating and melting ends of the tubes in a sterilized condition (see U.S. Pat. No. 4,507,119).

The disclosed tube connecting device comprises a set of blocks capable of holding in parallel two tubes to be connected with each other, and a wafer (plate-shaped heater element) movably disposed between the blocks so that it can transversely cross the tubes. The wafer is heated while the two tubes are held by the blocks in parallel and in opposing directions with each other. The heated wafer is moved to melt and cut the tubes. Then, one of the blocks is moved relative to the other block in a direction perpendicular to the tube until the axes of the two tubes meet together in a line, and the wafer is removed. The melted ends of the tubes are fused together.

The wafer employed in the tube connecting device of this type is provided with a resistor disposed between folded metal plates having insulation layers (adhesive layers). When the resistor is fed with electricity, it generates heat so that the entirety of the metal plate is heated (see U.S. Pat. No. 4,501,951).

The resistor of the wafer is formed by etching a stainless foil or a nickel-chromium foil, which is accompanied by the following disadvantage.

(1) The stainless foil or the like used there is manufactured by a thin plate rolling process and has the thickness of about 25 $\mu$ m, which usually shows an appreciable variation. The width of the resistor also varies due to the limitations of the etching process. Thus, the resistance of the resistor cannot be stably obtained, namely, an error within  $\pm 5\%$  in the designed resistance (eg 10.5 $\Omega$ ) can hardly be achieved.

(2) It is difficult to adjust the resistance of the resistor, since the resistor is formed of stainless foil or the like having the predetermined thickness and excessive etching can occur.

(3) The resistor made of stainless foil or the like is hard to adhere to the insulation layer of the wafer, since air is apt to enter into the gap between the resistor and the insulation layer. Hence, a portion of the resistor is often peeled off during manufacture

of the wafer and the resistance of the resistor is caused to vary. When the resistor is in use, an expansion in the wafer thickness occurs sometimes due to a temperature difference across the wafer and an increase in plate thickness. As a result, an imperfect fusion of the tubes is effected and leakage of the collected blood may occur by the imperfectly-connected tubes.

(4) Manufacturing the resistor by etching process requires a number of manufacturing steps, a long manufacturing time and high manufacturing costs.

Once the wafer has been used, it may preferably be discarded because the surface of the wafer is contaminated with melted resin of the tubes or blood contained in the tubes. For this purpose, an invention has been devised whereby it becomes possible to judge if the wafer is not new (see U.S. Pat. No. 4,647,756).

This wafer, having the above-described function, comprises a bypass fuse which is electrically connected between both terminals of the resistor. When the wafer is new, the voltage applied across both terminals of the resistor causes the current to bypass the resistor and flow in the fuse. After the fuse has been burnt out, the current flows in the resistor to generate heat. When the wafer is not new, the fuse is already gone. Therefore, when the voltage is applied across both terminals, the current flows in the resistor directly. It can be determined based on the difference between rise patterns of the applied voltages, whether the wafer is new or old. In this arrangement, an additional manufacturing step to connect the fuse is required after the resistor has been formed by etching, which however, brings an increase in the number of manufacturing steps, the manufacturing time and the manufacturing costs.

EP-A-0 103 977 discloses a heating element for welding thermoplastic tubes which comprises a folded sheet of metal and a resistor isolated from the sheet and disposed inside the fold of the sheet of metal.

EP-A-0 158 779 discloses a heating element for an iron which comprises a pattern of thick layer resistors made by screen printing bands of a conductive paste.

It is the object of the present invention to provide a heater element suitable for use in a tube connecting device, wherein a change in the resistance value of a resistor enables a person to test whether the heater element has already been used or not.

According to the present invention, for achieving the above object, there is provided a heater element, to which a predetermined voltage is applied, suitable for use in a tube connecting device, which comprises: a metal plate separated into two halves along a fold line; an insulation layer formed on one surface of said metal plate; a resistor formed on said insulation layer, for electrically generating heat; said resistor comprising a solidified conductive paste applied in a winding pattern on said insulation layer, said resistor having first and second ends, said conductive paste including a binder, a

pair of terminals respectively connected to both ends of said resistor; and means for applying a voltage across said pair of terminals to cause an electrical current to flow through said winding pattern of conductive paste for causing said resistor to generate heat, characterized in that the resistance of said resistor is variable by denaturation of said binder under electrical heating of the resistor itself.

The resistor in the heater element is formed by evaporating the solvent from the binder so as to solidify the binder after the desired pattern of the conductive paste has been printed by a screen printing process, so that the resistance of the so formed resistor is further varied by denaturation of the binder under electrical heating of said resistor itself.

According to the heater element of the present invention for the tube connecting device, as has been described above, when the resistor is formed by the screen printing method, the accuracy of dimensions of the resistor is improved. When the resistor is mass-produced, a variation in its resistance value is extremely low. Further, the resistance value of the resistor can be easily adjusted by varying the screen printing conditions.

Compared with the case where the resistor and the like are manufactured by etching, the number of steps for manufacturing the resistor and the like can be reduced and the resistor and the like can be easily manufactured. Further, the manufacturing time can be shortened and the manufacturing cost can be greatly reduced. Accordingly, the resistor and the like are suitable for the mass-production.

Further, since the resistor and the like produced by the screen printing method are not deteriorated and the properties of adhesion between the resistor and the like and the insulative layer are excellent, the resistor and the like are prevented from being separated out of the insulative layer.

Since the heater element of the present invention has a resistor whose resistance value varies before and after its energization, it can be determined, based on the result of measurement of the resistance value of the resistor, for example, which has been effected before its use, whether or not the heater element is new or old.

The above and other objects, features and advantages of the present invention will become apparent from the following description and the appended claims, taken in conjunction with the accompanying drawings in which a preferred embodiment of the present invention is shown by way of illustrative example.

FIG. 1 is a plan view showing one example of the structure of a heater element in a unfolded form according to the present invention;

FIG. 2 is a cross-sectional view taken along line II - II of FIG. 1;

FIG. 3 is a perspective view showing the example of the structure of the heater element shown in FIG. 1 in a folded form;

FIG. 4 is a perspective view illustrating one example of the structure of the tube connecting device;

FIG. 5 is a perspective view showing a step for connecting tubes using the tube connecting device shown in FIG. 4;

FIG. 6 is a perspective view illustrating another step for connecting tubes using the tube connecting device shown in FIG. 4;

FIG. 7 is a perspective view depicting a further step for connecting tubes to each other using the tube connecting device shown in FIG. 4;

FIG. 8 is a perspective view showing a still further step for connecting tubes using the tube connecting device shown in FIG. 4; and

FIG. 9 is a graph illustrating the manner in which the resistance of used and unused resistors change with time.

FIG. 1 is a plan view showing one example of the structure of a heater element (hereinafter called "wafer") in a unfolded form according to the present invention, which is suitable for use in a tube connecting device. FIG. 2 is a cross-sectional view taken along line II - II of FIG. 1. As shown in FIGS. 1 and 2, a wafer 1 comprises a metal plate 2, an insulation layer 3 formed substantially over the entire internal surface (i.e., the inner surface formed when the metal plate 2 is folded about a bend line 11 to be described later) of the metal plate 2, a resistor 4 which is formed on one surface of the insulation layer 3 which generates heat by electricity, and terminals 5 and 6 having relatively large areas which are respectively electrically connected to both ends of the resistor 4.

The metal plate 2 is made of a metal having a superior thermal conductivity to allow heat to be uniformly distributed along the surface of the metal. An exemplary suitable metal includes, for example, copper, aluminum, gold, silver, iron or alloy including these metals. Of these, copper or copper alloy with a copper content of 99.9% or higher by weight is particularly preferred. This type of metal is preferred because of uniformity of heating and the ease of processing.

Suitable thickness of the metal plate 2 depends on the material. However, the metal plate 2 may preferably have a thickness range of from 0.08mm to 0.12mm, particularly, 0.095mm to 0.105mm. If the thickness of the metal plate 2 is thicker than these values, then a difficulty in fusing of cut portions of the tubes arises. If, on the other hand, the thickness of the metal plate 2 is thinner than these values, then a difficulty in melting and cutting of the tubes arises.

The insulation layer 3 formed on the internal surface of the metal plate 2 electrically insulates the resistor 4 from the metal plate 2. Further, the insulation layer 3 serves as an adhesive layer to adhere a half plate 21 of the metal plate 2 on which the resistor is formed (a resistor constitutive portion 21) and another half plate 22 on which no resistor is formed (a resistor non-constitu-

tive portion 22). The two halves 21 and 22 are folded and stuck to each other. Therefore, the insulation layer 3 is required to maintain a desired adhesive force (secondary adhesive force) even after it has been printed, heated and dried.

Thus, materials for the insulation layer 3 may preferably have along with electrical insulating properties, heat-resisting properties (300°C to 350°C), solvent-resisting properties and flow-resisting properties, and may include, for example, epoxy resin, acrylic adhesive, room-temperature hardening type silicone adhesive, polyimide adhesive, polyimide resin, a modified acrylic adhesive, silicone-modified polyimide adhesive, etc.

The thickness of the insulation layer 3 is set to such a thickness that sufficient insulating properties between the resistor 4 and the metal plate 2 is secured. It may preferably range from 15µm to 50 µm, particularly from 20µm to 35 µm, depending on the materials. If the insulation layer 3 is excessively thick, then it becomes hard to transfer the heat through the insulation layer 3. If the insulation layer 3 is excessively thin, on the other hand, it becomes hard to obtain a desired thickness of the heater element 1 formed by folding the metal plate 2.

The insulation layer 3 may be formed, for instance, by applying a liquid including one of the above adhesive materials or their precursors on the internal surface of the metal plate 2 and hardening it.

On the insulation layer 3 formed on the resistor constitutive portion 21 side, there are formed the resistor 4 shaped in a desired pattern, the terminals (electrodes) 5 and 6 respectively electrically connected to both ends of the resistor 4, and a plurality of bars 7 arranged in noncontact with the resistor 4 and the terminals 5 and 6, the bars 7 being disposed around the terminals 5 and 6 and on one end of the resistor constitutive portion 21, which is located on the side opposite to the terminals 5 and 6. The resistor 4, the terminals 5 and 6 and the bars 7 (hereinafter called generically "resistor 4, etc.") are formed by a screen printing process or formed in a lump if appropriate.

In the present invention, the resistor 4, etc. may be formed by performing the screen printing process plural times. For example, after forming a combination of the resistor 4 and bars 7 with conductive paste of a composition, the terminals 5 and 6 may be formed with conductive paste of a different composition.

Grooves S are respectively defined between the adjacent bars 7. The grooves S are provided to discharge gas produced in the insulation layer 3 when the resistor constitutive portion 21 and the resistor non-constitutive portion 22 are bonded together under heat and pressure, along with gas produced in the semi-hardened resistor 4, to the outside. Further, the bars 7 can serve to maintain the thickness of the wafer 1 uniform.

Now, a description on the forming of the resistor 4, etc. will be given below in further detail.

First, the conductive paste is printed on the insulation layer 3 of the resistor constitutive portion 21 in a

desired pattern by using the screen printing process.

Conductive substances, which are major components of the conductive paste, are normally metallic particles. Among these, silver or silver alloy is particularly preferred.

As silver alloy, there may be Ag-Pd alloy, Ag-Pt alloy, Ag-Pd-Pt alloy or the like. Silver alloys containing Pd have excellent migration-resisting properties as compared with pure silver.

In a conductive paste, either silver or silver alloy normally exists in the form of particles, in order to increase intervals between the respective particles. The average diameter of the particles may preferably range from 0.5µm to 50µm, particularly, from 1µm to 10µm. If the average diameter of the particles is less than 0.5µm, then the degree of shrinkage of the resistor 4, etc. becomes large. If, on the other hand, the average diameter of the particles is larger than 50µm, then the printing properties and the dispersion properties of the conductive paste are lowered.

Vehicles of a conductive paste may include: binder such as epoxy resin, thermoset melamine resin, acrylic resin, nitrocellulose, ethylcellulose, phenolic resin, vinyl resin or the like; solvent such as butylcarbitol, terpeneol or the like; thermoplastic resin such as polyvinyl chloride for improving thermoplasticity; dispersant; activator; viscosity modifier; film adhesive-force accelerating substance (eg, metallic oxide); resistance regulating substance; etc. Among these, desired ones can be suitably mixed according to the purpose.

It may be preferable for a conductive paste to contain the vehicles in an amount of from about 10 to 75 wt. %. The conductive paste may preferably have a viscosity ranging from 300Ps to 400Ps (at 25°C) from the view point of printing properties and reproducibility of the resistor.

When the aforementioned conductive paste is used for the screen printing process, it is preferable to employ a screen having a mesh of 180 to 300, particularly, a mesh of 200 to 250.

The film thickness of the resistor 4, etc. in a hardened state may preferably range from about 10µm to 40µm, more preferably, about 20µm to 30µm. This is because a desired heat can be generated. The film thickness can be easily set by varying conditions in the screen printing process, such as the thickness of screening emulsion, the rubber hardness of squeegee, an interval between the screen and an object to be printed, the rate of movement of the squeegee, etc.

In the present invention, the conditions such as the composition, viscosity and film thickness of the conductive paste may differ in each of the resistor 4, the terminals 5 and 6 and the bars 7.

Next, the conductive paste printed in the predetermined pattern on the insulation layer 3 is dried and hardened using an oven or a hot-air type drier. Suitable conditions for drying and hardening the conductive paste may be about 150°C to 200°C in temperature and about

5 to 30 minutes in time.

It is preferable to set the resistance of the so-formed resistor 4 to range from  $8\Omega$  to  $16\Omega$ , particularly from  $8\Omega$  to  $12\Omega$ .

Accuracy in dimensions of the resistor is improved, since the resistor is formed by the screen printing process, and an extremely low variation in resistance of the resistor can be attained. That is, an error within  $\pm 5\%$ , particularly within  $\pm 1.5\%$ , in the resistance can be achieved. Further, the resistance of the resistor can easily be adjusted by varying conditions in the screen printing process.

The number of manufacturing steps, manufacturing time and manufacturing costs can greatly be reduced, even when a complex and fine pattern of the resistor 4, etc. is employed, compared to the conventional etching process of manufacturing the resistor.

Further, the resistor 4, etc. produced by the screen printing process adhere to the insulation layer 3 firmly enough to prevent the resistor 4, etc. from being peeled off from the insulation layer 3 during production.

Moreover, the resistor 4, etc. produced by the screen printing process have excellent heat-resistant properties. Deterioration, such as a crack in the film, is hard to occur even under a rapid temperature change, particularly, under a temperature rise at the time when the resistor constitutive portion 21 and the resistor non-constitutive portion 22 are bonded together under heat and pressure, as described later.

In forming the resistor 4, etc., a main adhesive portion 31 in which the resistor 4, etc. are not formed may preferably be provided on the side (right side as viewed in FIG. 1) opposite to the bend line 11 of the resistor constitutive portion 21. A strong adhesive force between the resistor constitutive portion 21 and the resistor non-constitutive portion 22 when they are stucked together can be provided by the main adhesive portion 31.

As shown in FIG. 1, the resistor non-constitutive portion 22 has two openings 8 and 9 defined there-through. When the metal plate 2 is bent along the bend line 11 and the resistor constitutive portion 21 and the resistor non-constitutive portion 22 are stucked together, the openings 8 and 9 are located in positions respectively corresponding to the terminals 5 and 6. As shown in FIG. 3, central portions of the terminals 5 and 6 are exposed through the openings 8 and 9 when the metal plate 2 is folded, to which an electrical source is connected.

Incidentally, the shape of the openings 8 and 9 is not necessarily limited to the circle shown in FIG. 1. It can be an ellipse, a triangle, a square, a hexagon or the like.

After the resistor 4, etc. have been formed, the metal plate 2 is folded along the bend line 11 so that the resistor 4, etc. are included inside. Simultaneously, the resistor constitutive portion 21 and the resistor non-constitutive portion 22 are stucked together and bonded to each other under heat and pressure to complete the

heating element or wafer 1 shown in FIG. 3.

The heat and pressure conditions in the bonding of the resistor constitutive portion 21 and the resistor non-constitutive portion 22 are decided depending on the materials and thickness of the insulation layer 3. However, a temperature ranging from  $170^\circ\text{C}$  to  $260^\circ\text{C}$  and a pressure ranging from  $5\text{ kg/cm}^2$  to  $40\text{ kg/cm}^2$  are preferable.

A cut portion 10 shaped in the form of a triangle, for example, may be provided in the corner of the wafer 1, on the side opposite to where the openings 8 and 9 are and positioned on the bend line 11, as shown in FIG. 3. The cut portion 10 serves as a guide in moving the wafer 1.

The wafer 1 may be manufactured one by one, however, it is more preferable to produce plural wafers at once, from the productivity point of view. In this situation, a plurality of insulation layers 3 and resistors 4 are formed simultaneously on a large metal plate, individual metal plate 2 is cut from the large one, and the openings 8 and 9 are formed in each of them by a punching process, for example.

Now, a description will be made on the structure of a tube connecting device using the wafer 1 according to the present invention.

FIG. 4 is a perspective view showing one example of the structure of a tube connecting device 40. FIGS. 5 through 8 are respectively perspective views illustrating steps for connecting tubes 14 and 15 to one another using the tube connecting devices 40. Apparent from the figures, the tube connecting devices 40 comprises a set of holders 41 and 42, and a wafer 1 according to the present invention replaceably disposed between the holders. Two tubes 14 and 15, made of polyvinyl chloride, for example, are held side by side in the holders 41 and 42, respectively, and melted and cut by the heated wafer 1. While cut ends of the tubes 14 and 15 are in a melted state, one of the holders, 41, is moved, and then the wafer 1 is removed. Thereafter, the melted ends of the tubes 14 and 15 are fused together.

The holders 41 and 42 respectively comprise holder components 411, 412 and 421, 422 as the upper and lower sides of the respective holders. The holder components 411 and 421 are respectively swingable about supports 44.

Grooves 45 and 46 each having a semicircular cross-section are respectively provided in the opposing inner surfaces of the holder components 411 and 412. The holder components 421 and 422 also have the same grooves. Thus, a pair of holes 47 and 48 for holding tubes therein are formed in the holder 41 when the holder components 411 and 412 are closed. The holes 47 and 48 are formed also in the holder 42. A tube clamping (not shown) for pressing and blocking the tube when the holder components 411 and 412 (421 and 422) are closed may be provided inside of each of the holes 47 and 48 of the respective holders.

How to use the tube connecting device 40 will now

be described below.

As shown in FIG. 5, the tubes 14 and 15 are laid in parallel for a predetermined length in such a manner that closed ends 16 and 17 of the tubes 14 and 15 directing opposite to each other. Then, the tubes 14 and 15 are respectively inserted into the grooves 45 and 46 of the holders 41 and 42. Thereafter, the holder components 411, 412 and 421, 422 are closed so that the two tubes 14 and 15 are fixedly held by the holes 47 and 48.

Next, a voltage of 15V to 24V, for example, is applied across the terminals 5 and 6 of the wafer 1 by an unillustrated voltage applying means to cause an electric current to flow in the resistor 4 of the wafer 1. The resistor 4 generates heat and hence the wafer 1 is heated to a temperature (of about 260°C to 320°C, for example) higher than the melting point of the tubes 14 and 15.

When the wafer 1 is moved upward as shown in FIG. 6 in this condition, the tubes 14 and 15 are melted and cut by the heat of the wafer 1. At this time, the cut ends of the tubes 14 and 15 are at a high temperatures under a melted or softened state, and not in communication with the outside since the wafer 1 is in contact with the cut ends, a sterilized state is maintained there.

While the cut ends of the tubes 14 and 15 are being held in the melted state, the holder 41 is moved in a direction indicated by the arrow in FIG. 7. Thereafter, the holder 41 is stopped and fixed at the position where the sections of the cut tubes 14 and 15 are facing to each other.

Next, the wafer 1 is pulled out downward as shown in FIG. 8. Thereafter, the holder 41 is pressed toward the holder 42 as necessary. As a result, the sections of the melted tubes 14 and 15 are fused together so that both tubes 14 and 15 are coupled to each other.

In a series of operations from the cutting to the connection of the tubes 14 and 15 using the wafer 1, the sections of the tubes 14 and 15 and their peripheral areas are at the high temperature in the melted or softened state. Further, the sections of the tubes contact closely to the surface of the wafer 1 which is maintained at a high temperature, and are hindered from communicating with the outside, until the connection is completed. Thus, the sterilized state of the tubes is perfectly maintained.

After the tubes 14 and 15 have been connected, tube members 14' and 15' including the closed ends 16 and 17 are removed to be discarded.

It is desirable that the used wafer is replaced with a new wafer 1 when other tubes are cut and connected. That is, a disposable or single use of the wafer 1 is preferred in the invention. This necessitates the wafer to provide detectability of whether the wafer is new or not, when it is used.

The wafer according to the present invention is constructed in such a manner that the resistance of the resistor 4 varies before and after its use. Such a wafer may have the same construction as the aforementioned

wafer 1 except for the differences which will be described below.

Namely, the conditions (temperature and/or time) of drying and hardening the conductive paste printed to form the resistor 4, etc. on the insulation layer 3 of the wafer 1 are adjusted so that the solvent in the binder of the conductive paste is evaporated to merely solidify the binder. Incidentally, the drying and hardening conditions mentioned above should be determined by considering the heat applied when the resistor constitutive component 21 and the resistor non-constitutive component 22 are bonded to each other under heat and pressure after formation of the resistor 4, etc.

Once such a resistor 4 is energized, it heats itself and the so-solidified binder is further denatured by the heat so that the resistance of the resistor 4 is reduced.

FIG. 9 is a graph illustrating the manner of variation in the resistance of the resistor 4 with time. The graph shows a change in the resistance of the resistor 4 when a dc voltage (of 15V to 20V, for example) is applied across the terminals 5 and 6 of the wafer 1. The surface temperature of the wafer 1 is caused to reach 275°C after about 6 seconds, the voltage is then controlled so as to maintain the surface temperature of the wafer 1 at 275°C for 3 seconds, and thereafter the application of the voltage is stopped to cool the wafer 1 down to the room temperature.

As indicated by the graph, a curve indicative of a variation in the resistance of a resistor 4 in an unused wafer (indicated by the dotted line in the graph) differs from that in a used wafer (indicated by the solid line). That is, the resistance of the resistor 4 in the unused wafer is relatively high throughout the entire process, whereas the resistance in the used wafer is low throughout the entire process, because the binder in the conductive paste is denatured by the heat generated during the use of the wafer.

Whether the wafer is new or old can be determined by measuring the resistance (or voltage) of the resistor 4 in a predetermined occasion. Thus, the used wafer can be safely avoided from being re-used inadvertently.

To manufacture such a resistance varying wafer 1, it is only necessary to adjust the conditions of drying and hardening the conductive paste. Such a wafer 1 does not need a change in its circuit configuration and the provision of other parts. Therefore, the easiness and costs in the manufacture of the wafer can be maintained unchanged.

Incidentally, the resistance varying wafer is not necessarily limited to one having the above structure. The wafer may have, for example, a structure in which the resistance of the resistor 4 is varied by denaturation of components of the conductive paste such as the conductive substance, the vehicle or the like, or variation in the orientation or linkage states of the components caused by the application of electricity or a temperature change.

A description has been given above of one example

of the heater element according to the present invention. However, the present invention is not necessarily limited to the structure referred to above. For example, the terminals 5 and 6 may be those manufactured by a method other than the screen printing process. Further, the terminals 5 and 6 may be such that are projecting from the outer peripheral edge of the metal plate 2.

In the heater element according to the present invention, since the resistor is formed by the screen printing process, as has been described above, the following advantageous effects are realized.

Accuracy in dimensions of the resistor is improved, and an extremely low variation in resistance of the resistor can be attained. Further, the resistance of the resistor can easily be adjusted by varying conditions in the screen printing process.

The number of manufacturing steps, manufacturing time and manufacturing costs can greatly be reduced, compared to the conventional etching process of manufacturing the resistor.

Further, the resistor produced by the screen printing process adheres to the insulation layer strongly enough to prevent the resistor from being peeled off.

By measuring the resistance of the resistor, it can easily be determined whether the heater element is new or old, since the resistance of the resistor varies before and after the use due to thermal denaturation of binder in the resistor formed of the conductive paste.

Further, the resistor whose resistance value varies before and after its energization can be manufactured by the screen printing method, for example. The resistor can be easily produced by simply controlling the conditions for drying and hardening the conductive paste. It is therefore unnecessary to change a circuit configuration and additionally provide other parts as in the conventional wafer. Further, the heater element according to the present invention can be easily manufactured and the manufacturing cost can also be greatly reduced.

#### Claims

1. A heater element (1), to which a predetermined voltage is applied, suitable for use in a tube connecting device, comprising :

a metal plate (2), separated into two halves (21,22) along a fold line (11) ;  
an insulation layer (3) formed on one surface of said metal plate (2) ;  
a resistor (4) formed on said insulation layer (3), for electrically generating heat ;

said resistor (4) comprising a solidified conductive paste applied in a winding pattern on said insulation layer (3), said resistor (4) having first and second ends, said conductive paste including a binder ;  
a pair of terminals (5,6) connected to said first and

second ends, respectively, of said resistor (4), and a means for applying a voltage across said pair of terminals (5,6) to cause an electrical current to flow through said winding pattern of conductive paste for causing said resistor (4) to generate heat ;  
characterized in that the resistance value of said resistor (4) is variable by denaturation of said binder under electrical heating of the resistor itself.

2. A heater element according to claim 1, wherein said metal plate (2) is made of either copper or copper alloy containing at least 99,9 wt% of copper.
3. A heater element according to claim 1 or 2, wherein said metal plate (2) has a thickness ranging from 0.08mm to 0.12mm.
4. A heater element according to claim 3, wherein said metal plate (2) has a thickness ranging from 0.09mm to 0.105mm.
5. A heater element according to claim 1, wherein the conductive substance of said conductive paste is either silver or a silver alloy.
6. A heater element according to claim 5, wherein said silver or silver alloy comprises particles whose average diameter ranges from 0,5µm to 50µm.
7. A heater element according to claim 6, wherein said silver or silver alloy comprises particles whose average diameter ranges from 1µm to 10µm.
8. A heater element according to claim 1, wherein a plurality of bars (7) and grooves are provided adjacent to said resistor (4) on said insulation layer (3), each of said grooves being respectively defined between two bars, for communicating with an outside of the heater element.
9. A heater element according to claim 8, wherein said resistor (4) and said plurality of bars (7) are formed of the same conductive paste.
10. A heater element according to claim 8, wherein each of said bars (7) has a film thickness ranging from 10µm to 40µm, after said conductive paste has solidified.
11. A heater element according to claim 10, wherein each of said bars (7) has a film thickness ranging from 20µm to 30µm, after said conductive paste has solidified.
12. A heater element according to claim 1, wherein an adhesive portion (31) is provided in the vicinity of said resistor (4) on a resistor constitutive portion (21) of said metal plate (2) for bonding said resistor

constitutive portion (21) and a resistor non-constitutive portion (22) of said metal plate.

13. A heater element according to claim 1, wherein said solidified conductive paste is formed by evaporation of the solvent to solidify the binder. 5
14. A heater element according to claim 1, wherein said resistor (4) has a film thickness ranging from 10µm to 40µm after said conductive paste has solidified. 10
15. A heater element according to claim 1, wherein said resistor (4) has a film thickness ranging from 20µm to 30µm after said conductive paste has solidified. 15
16. A heater element according to claim 1, wherein said insulation layer (3) is made of one material chosen from a group consisting of epoxy resin, acrylic adhesive, silicon adhesive and polyimide adhesive and polyimide resin. 20
17. A heater element according to claim 1, wherein said insulation layer has a thickness ranging from 15µm to 50µm. 25
18. A heater element according to claim 1, wherein said insulation layer has a thickness ranging from 20µm to 35µm. 30

#### Patentansprüche

1. Heizelement (1), welches mit einer bestimmten Spannung beaufschlagt wird, geeignet zur Verwendung in einer Schlauch-Ankuppel-Anordnung, welches aufweist:  
  - eine Metallplatine (2), welche durch eine Faltlinie (11) in zwei Hälften (21, 22) geteilt ist;
  - eine Isolierschicht (3), welche auf einer Oberfläche der Metallplatine (2) angeordnet ist;
  - einen Widerstand (4) zur elektrischen Erzeugung von Wärme, welcher auf der Isolierschicht (3) angeordnet ist, wobei der Widerstand (4) aufweist:
  - eine verfestigte Leitpaste, welche in gewundener Struktur auf die Isolierschicht (3) aufgebracht ist, wobei der Widerstand (4) ein erstes und ein zweites Ende hat, und wobei die die Leitpaste ein Bindemittel enthält;
  - ein Paar von Polen (5, 6), welche jeweils mit dem ersten und zweiten Ende des Widerstandes (4) verbunden sind sowie eine Vorrichtung für die an das Polpaar (5, 6) anzulegende Spannung, um einen elektrischen Stromfluß durch die gewundene Struktur der Leitpaste hervorzurufen, damit der Widerstand (4) Wärme erzeugt; **dadurch gekennzeichnet**, daß

der Widerstandswert des Widerstands (4) durch Denaturierung des Bindemittels unter der elektrischen Eigenerwärmung des Widerstands veränderbar ist.

2. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß die Metallplatine 2 aus reinem Kupfer oder einer Kupferlegierung, welche mindestens 99,9 % Kupfer enthält, besteht.
3. Heizelement gemäß Anspruch 1 oder 2, **dadurch gekennzeichnet**, daß die Metallplatine (2) eine Dicke von 0,08 mm bis 0,12 mm aufweist.
4. Heizelement gemäß Anspruch 3, **dadurch gekennzeichnet**, daß die Metallplatine (2) eine Dicke von 0,09 mm bis 0,105 mm aufweist.
5. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß die leitende Substanz der Leitpaste reines Silber oder eine Silberlegierung ist.
6. Heizelement gemäß Anspruch 5, **dadurch gekennzeichnet**, daß das Silber oder die Silberlegierung aus Teilchen besteht, deren mittlerer Durchmesser zwischen 0,5 µm und 50 µm liegt.
7. Heizelement gemäß Anspruch 6, **dadurch gekennzeichnet**, daß das Silber oder die Silberlegierung aus Teilchen besteht, deren mittlerer Durchmesser zwischen 1 µm und 10 µm liegt.
8. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß eine Anzahl von Stäbchen (7) und Rillen angrenzend an den Widerstand (4) auf der Leitschicht (3) angeordnet ist, wobei die einzelnen Rillen jeweils zwischen zwei Stäbchen definiert sind und eine Verbindung des Heizelements nach außen herstellen.
9. Heizelement gemäß Anspruch 8, **dadurch gekennzeichnet**, daß der Widerstand (4) und die Stäbchen (7) aus derselben Leitpaste ausgebildet sind.
10. Heizelement gemäß Anspruch 8, **dadurch gekennzeichnet**, daß jedes der Stäbchen (7) eine Dicke von 10 µm bis 40 µm hat, nachdem die Leitpaste ausgehärtet ist.
11. Heizelement gemäß Anspruch 10, **dadurch gekennzeichnet**, daß jedes der Stäbchen (7) eine Schichtdicke aufweist, die nach dem Aushärten der Leitpaste zwischen 20 µm und 30 µm liegt.
12. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß ein Haftbereich (31) in der Nähe des Widerstandes (4) auf einem Widerstands-



abschnitt (21) der Metallplatine (2) zum Verbinden des Widerstandsabschnitts (21) mit einem Nichtwiderstandsabschnitt (22) der Metallplatine ausgeführt ist.

13. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß die verfestigte Leitpaste erzeugt wird durch das Verdampfen des Lösungsmittels zum Verfestigen des Bindemittels.
14. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß der Widerstand (4) nach Aushärtung der Leitpaste eine Schichtdicke von 10 µm bis 40 µm aufweist.
15. Heizelement gemäß Anspruch 14, **dadurch gekennzeichnet**, daß der Widerstand (4) nach Aushärtung der Leitpaste eine Schichtdicke zwischen 20 µm und 30 µm aufweist.
16. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß die Isolierschicht (3) aus einem Material hergestellt wird, welches aus einer Gruppe gewählt wurde, die sich aus Epoxidharz, Acrylkleber, Silikonkleber, Polyamidkleber und Polyamidharz zusammensetzt.
17. Heizelement gemäß Anspruch 1, **dadurch gekennzeichnet**, daß die Isolierschicht eine Dicke zwischen 15 µm und 50 µm aufweist.
18. Heizelement gemäß Anspruch 17, **dadurch gekennzeichnet**, daß die Isolierschicht eine Dicke zwischen 20 µm und 35 µm hat.

#### Revendications

1. Élément à organe de chauffage (1) auquel est appliquée une tension prédéterminée et qui peut être utilisé dans un appareil de raccordement de tubes, comprenant :  
  
une plaque métallique (2) séparée en deux parties (21, 22) le long d'une ligne de pliage (11),  
une couche isolante (3) formée sur une première surface de la plaque métallique (2),  
une résistance (4) formée sur la couche isolante (3) et destinée à créer électriquement de la chaleur,  
la résistance (4) comprenant une pâte conductrice solidifiée appliquée suivant un dessin de spires sur la couche isolante (3), la résistance (4) ayant des première et seconde extrémités, la pâte conductrice contenant un liant, et  
une paire de bornes (5, 6) raccordées à la première et à la seconde extrémité respectivement de la résistance (4), et un dispositif d'applica-

tion d'une tension entre les deux bornes (5, 6) pour provoquer la circulation d'un courant électrique dans le dessin de spires de la pâte conductrice de manière que la résistance (4) dégage de la chaleur,

caractérisé en ce que la valeur de la résistance (4) est variable par dénaturation du liant soumis au chauffage électrique de la résistance elle-même.

2. Élément à organe de chauffage selon la revendication 1, dans lequel la plaque métallique (2) est formée de cuivre ou d'un alliage de cuivre contenant au moins 99,9 % en poids de cuivre.
3. Élément à organe de chauffage selon la revendication 1 ou 2, dans lequel la plaque métallique (2) a une épaisseur comprise entre 0,08 et 0,12 mm.
4. Élément à organe de chauffage selon la revendication 3, dans lequel la plaque métallique (2) a une épaisseur comprise entre 0,09 et 0,105 mm.
5. Élément à organe de chauffage selon la revendication 1, dans lequel la substance conductrice de la pâte conductrice est l'argent ou un alliage d'argent.
6. Élément à organe de chauffage selon la revendication 5, dans lequel l'argent ou l'alliage d'argent comporte des particules dont le diamètre moyen est compris entre 0,5 et 50 µm.
7. Élément à organe de chauffage selon la revendication 6 dans lequel l'argent ou l'alliage d'argent comprend des particules dont le diamètre moyen est compris entre 1 et 10 µm.
8. Élément à organe de chauffage selon la revendication 1, dans lequel plusieurs barres (7) et gorges sont placées près de la résistance (4) sur la couche isolante (3), chacune des gorges étant délimitée respectivement entre deux barres, afin qu'elle assure la communication avec l'extérieur de l'élément à organe de chauffage.
9. Élément à organe de chauffage selon la revendication 8, dans lequel la résistance (4) et les barres (7) sont formées de la même pâte conductrice.
10. Élément à organe de chauffage selon la revendication 8, dans lequel chacune des barres (7) a une épaisseur de film comprise entre 10 et 40 µm après solidification de la pâte conductrice.
11. Élément à organe de chauffage selon la revendication 10, dans lequel chacune des barres (7) a une épaisseur de film comprise entre 20 et 30 µm, après solidification de la pâte conductrice.

12. Elément à organe de chauffage selon la revendication 1, dans lequel une partie adhésive (31) est formée au voisinage de la résistance (4) sur une partie (21) constitutive de résistance de la plaque métallique (2) afin que la partie (21) constitutive de résistance et une partie (22) non constitutive de la résistance de la plaque métallique soient collées. 5
13. Elément à organe de chauffage selon la revendication 1, dans lequel la pâte conductrice solidifiée est formée par évaporation du solvant afin que le liant soit solidifié. 10
14. Elément à organe de chauffage selon la revendication 1, dans lequel la résistance (4) a une épaisseur de film comprise entre 10 et 40  $\mu\text{m}$  après solidification de la pâte conductrice. 15
15. Elément à organe de chauffage selon la revendication 1, dans lequel la résistance (4) a une épaisseur de film comprise entre 20 et 30  $\mu\text{m}$  après solidification de la pâte conductrice. 20
16. Elément à organe de chauffage selon la revendication 1, dans lequel la couche isolante (3) est formée d'un matériau choisi dans le groupe constitué par une résine époxyde, un adhésif acrylique, un adhésif de silicone, un adhésif de polyimide et une résine de polyimide. 25
17. Elément à organe de chauffage selon la revendication 1, dans lequel la couche isolante a une épaisseur comprise entre 15 et 50  $\mu\text{m}$ . 30
18. Elément à organe de chauffage selon la revendication 1, dans lequel la couche isolante a une épaisseur comprise entre 20 et 35  $\mu\text{m}$ . 35

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FIG.1

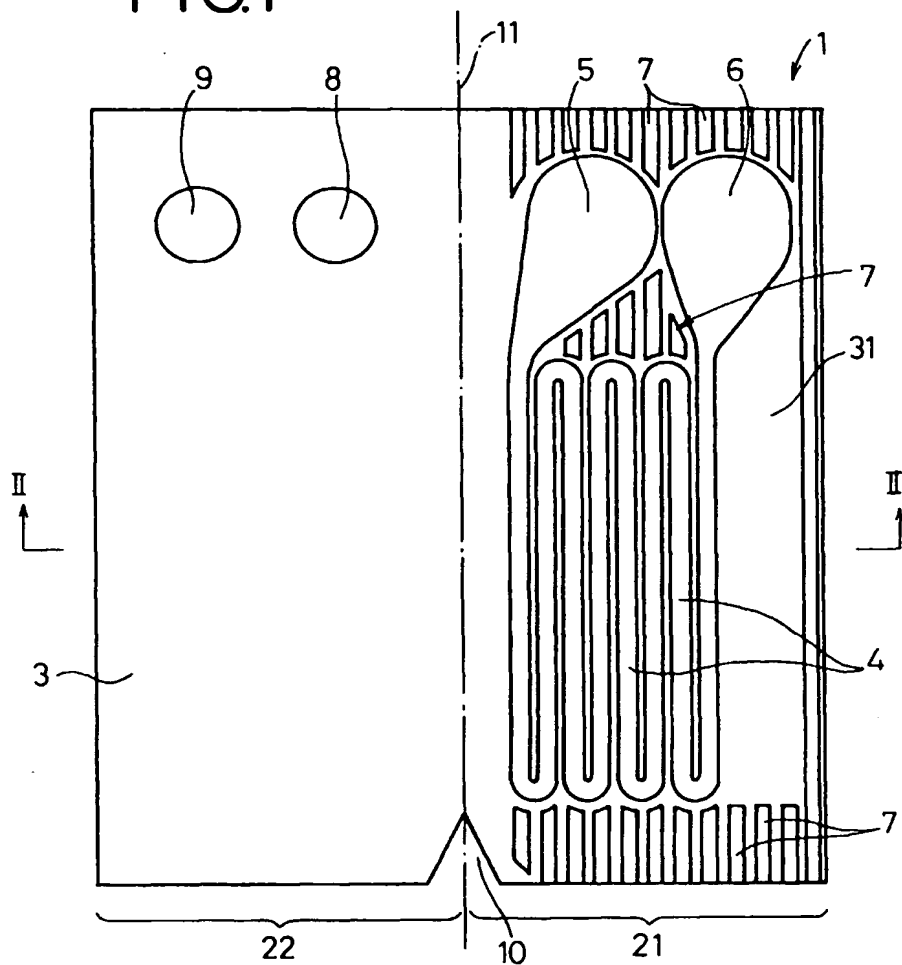


FIG.2

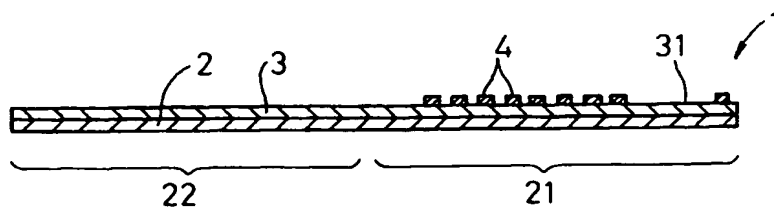


FIG.3

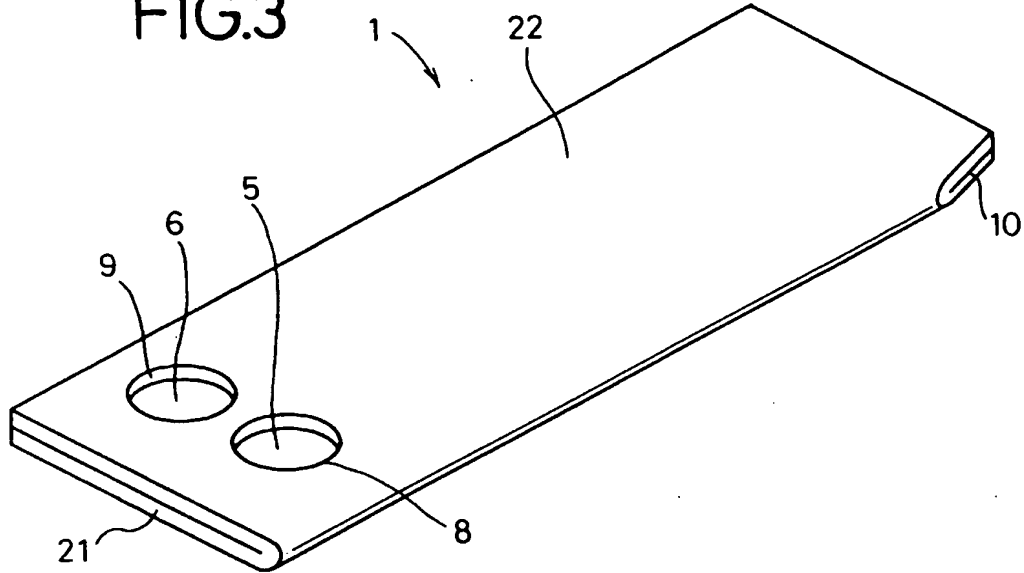


FIG.4

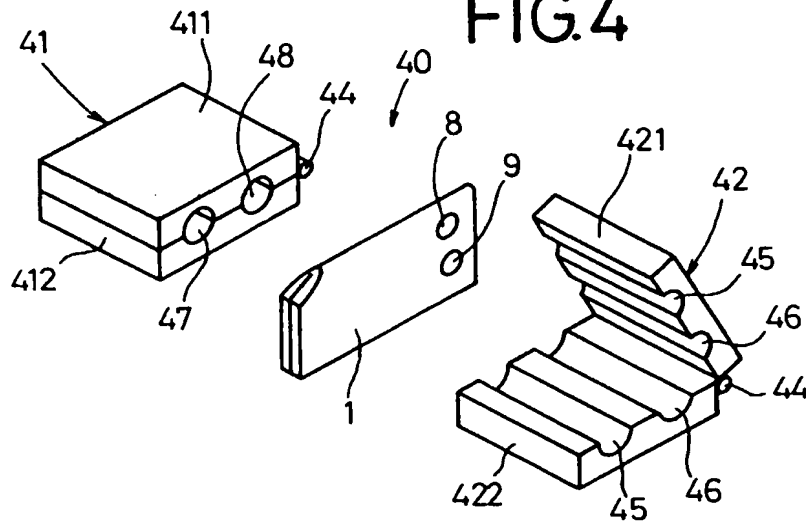


FIG.5

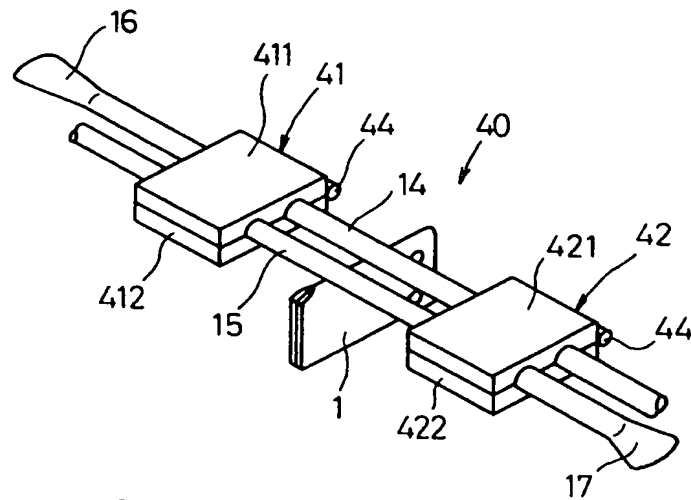


FIG.6

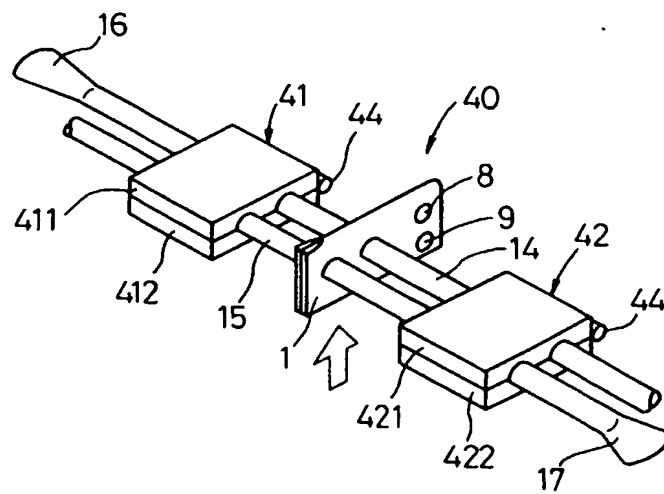


FIG.7

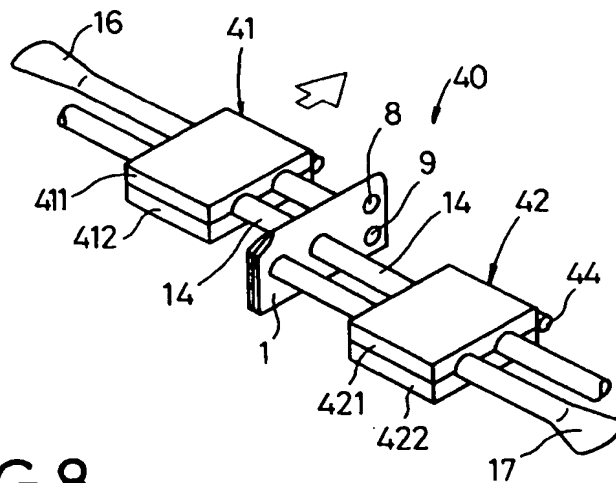


FIG.8

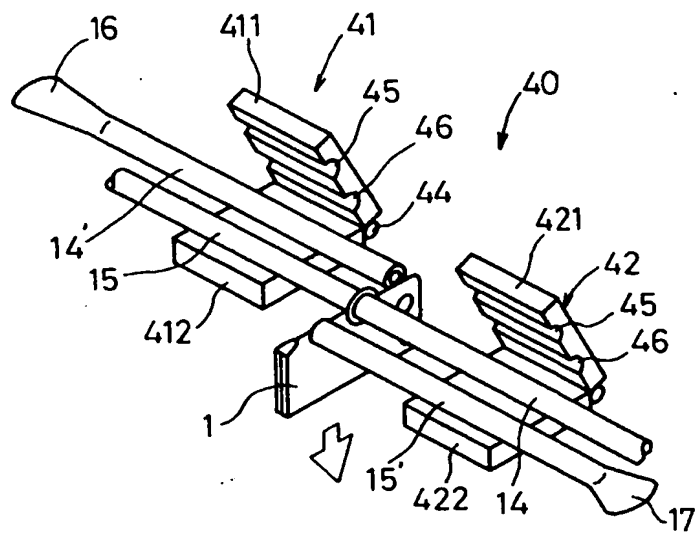


FIG.9

